NSN 5962-00-251-3444

Digital Microcircuit - Page 1 of 1



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Between 0.240 inches and 0.260 inches Body Height: 0.090 inches Maximum Power Dissipation Rating: 245.0 milliwatts Operating Tempurature Range: -55.0/+125.0 degrees celsius Storage Tempurature Range: -65.0/+125.0 degrees celsius Features Provided: Hermetically sealed Inclosure Material: Ceramic Inclosure Material: Ceramic Inclosure Configuration: Flat pack Output Logic Form: Transistor-transistor logic Input Circuit Pattern: Dual 4 input Design Function And Quantity: 2 gate, nand-nor Special Features: High reliability screening required Test Data Document: 49671-8994706 drawing (this is the basic governing drawing, such as a contractor drawing, original equipment manufacturer drawing, etc.; excludes any specification, standard or other document that may be referenced in a basic governing drawing) Sheff Life: N/a Unit Of Measure: Demilitarization: Yes - demil/mil	Body Length:
Bedween 0.240 inches and 0.260 inches Body Height: 0.090 inches Maximum Power Dissipation Rating: 245.0 milliwatts Operating Tempurature Range: -55.0/+125.0 degrees celsius Storage Tempurature Range: -65.0/+175.0 degrees celsius Storage Tempurature Range: -66.0/+175.0 degrees celsius Features Provided: Hermetically sealed Inclosure Material: Ceramic Inclosure Material: Ceramic Inclosure Configuration: Filat pack Output Logic Form: Transistor-transistor logic Input Circuit Pattern: Dual 4 input Design Function And Quantity: 2 gate, nand-nor Special Features: High reliability screening required Test Data Document: 49671-8994706 drawing (this is the basic governing drawing, such as a contractor drawing, original equipment manufacturer drawing, etc.: excludes any specification, standard or other document that may be referenced in a basic governing drawing) Shelf Life: N/a Unit Of Measure: Demilitarization: Yes - demil/mil	Between 0.365 inches and 0.385 inches
Body Height: 0.090 inches Maximum Power Dissipation Rating: 245.0 milliwatts Operating Tempurature Range: -55.0/+125.0 degrees celsius Storage Tempurature Range: -65.0/+125.0 degrees celsius Storage Tempurature Range: -65.0/+125.0 degrees celsius Features Provided: Hermetically sealed Inclosure Material: Ceramic Inclosure Material: Ceramic Inclosure Configuration: First pack Output Logic Form: Transistor-transistor logic Input Circuit Pattern: Dual 4 input Dussign Function And Quantity: 2 gate, nand-nor Special Features: High reliability screening required Test Data Document: 49671-8994706 drawing (this is the basic governing drawing, such as a contractor drawing, original equipment manufacturer drawing, etc.; excludes any specification, standard or other document that may be referenced in a basic governing drawing) Shelf Life: N/a Unit Of Measure: Demilitarization: Yes - demil/mil Filg:	Body Width:
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Input Circuit Pattern: Dual 4 input Design Function And Quantity: 2 gate, nand-nor Special Features: High reliability screening required Test Data Document: 49671-8994706 drawing (this is the basic governing drawing, such as a contractor drawing, original equipment manufacturer drawing, etc.; excludes any specification, standard or other document that may be referenced in a basic governing drawing) Shelf Life: N/a Unit Of Measure: Demilitarization: Yes - demil/mli Fiig:	Output Logic Form:
Dual 4 input Design Function And Quantity: 2 gate, nand-nor Special Features: High reliability screening required Test Data Document: 49671-8994706 drawing (this is the basic governing drawing, such as a contractor drawing, original equipment manufacturer drawing, etc.; excludes any specification, standard or other document that may be referenced in a basic governing drawing) Shelf Life: N/a Unit Of Measure: Demilitarization: Yes - demil/mli Fitig:	Transistor-transistor logic
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2 gate, nand-nor Special Features: High reliability screening required Test Data Document: 49671-8994706 drawing (this is the basic governing drawing, such as a contractor drawing, original equipment manufacturer drawing, etc.; excludes any specification, standard or other document that may be referenced in a basic governing drawing) Shelf Life: N/a Unit Of Measure: Demilitarization: Yes - demil/mli Fiig:	Dual 4 input
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Unit Of Measure: Demilitarization: Yes - demil/mli Fiig:	Shelf Life:
Demilitarization: Yes - demil/mli Fiig:	N/a
Yes - demil/mli Fiig:	Unit Of Measure:
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